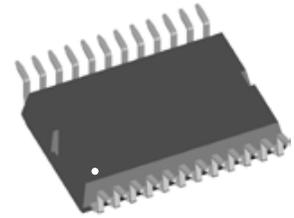
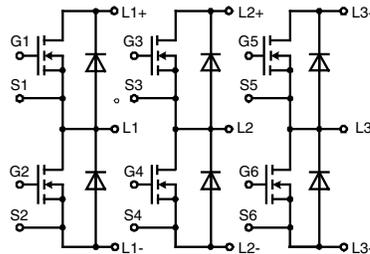


Three phase full Bridge

with Trench MOSFETs
in DCB isolated high current package

$V_{DSS} = 150\text{ V}$
 $I_{D25} = 57\text{ A}$
 $R_{DSon\text{ typ.}} = 17\text{ m}\Omega$



MOSFETs		Maximum Ratings				
Symbol	Conditions					
V_{DSS}	$T_{VJ} = 25^{\circ}\text{C to } 150^{\circ}\text{C}$	150	V			
V_{GS}		± 20	V			
I_{D25}	$T_C = 25^{\circ}\text{C}$	57	A			
I_{D90}	$T_C = 90^{\circ}\text{C}$	45	A			
I_{D110}	$T_C = 110^{\circ}\text{C}$	43	A			
I_{F25}	$T_C = 25^{\circ}\text{C}$ (diode)	tbd	A			
I_{F90}	$T_C = 90^{\circ}\text{C}$ (diode)	tbd	A			
I_{F110}	$T_C = 110^{\circ}\text{C}$ (diode)	tbd	A			
Symbol		Characteristic Values				
($T_{VJ} = 25^{\circ}\text{C}$, unless otherwise specified)						
		min.	typ.	max.		
$R_{DSon}^{1)}$	on chip level at		17	22	$\text{m}\Omega$	
	$V_{GS} = 10\text{ V}$		36		$\text{m}\Omega$	
	$T_{VJ} = 25^{\circ}\text{C}$					
	$T_{VJ} = 125^{\circ}\text{C}$					
$V_{GS(th)}$	$V_{DS} = 20\text{ V}; I_D = 1\text{ mA}$	2.5		4.5	V	
I_{DSS}	$V_{DS} = V_{DSS}; V_{GS} = 0\text{ V}$		0.1	1	μA	
	$T_{VJ} = 25^{\circ}\text{C}$				mA	
	$T_{VJ} = 125^{\circ}\text{C}$					
I_{GSS}	$V_{GS} = \pm 20\text{ V}; V_{DS} = 0\text{ V}$			0.2	μA	
Q_g	$V_{GS} = 10\text{ V}; V_{DS} = 65\text{ V}; I_D = 50\text{ A}$		tbd		nC	
Q_{gs}			tbd		nC	
Q_{gd}			tbd		nC	
$t_{d(on)}$	inductive load $V_{GS} = 10\text{ V}; V_{DS} = 96\text{ V}$ $I_D = 50\text{ A}; R_G = 33\ \Omega;$ $T_J = 125^{\circ}\text{C}$		tbd		ns	
t_r			tbd		ns	
$t_{d(off)}$			tbd		ns	
t_f			tbd		ns	
E_{on}				tbd		mJ
E_{off}				tbd		mJ
E_{recoff}			tbd		mJ	
R_{thJC}	with heat transfer paste (IXYS test setup)		1.3	1.0	K/W	
R_{thJH}				1.6	K/W	

¹⁾ $V_{DS} = I_D \cdot (R_{DS(on)} + 2R_{Pin\text{ to Chip}})$

Applications

- AC drives
 - in automobiles
 - electric power steering
 - starter generator
 - in industrial vehicles
 - propulsion drives
 - fork lift drives
- in battery supplied equipment

Features

- MOSFETs in trench technology:
 - low R_{DSon}
 - optimized intrinsic reverse diode
- package:
 - high level of integration
 - high current capability
 - aux. terminals for MOSFET control
 - terminals for soldering or welding connections
 - isolated DCB ceramic base plate with optimized heat transfer
- Space and weight savings

Source-Drain Diode

Symbol	Conditions	Characteristic Values			
		min.	typ.	max.	
V_{SD}	(diode) $I_F = 50\text{ A}$; $V_{GS} = 0\text{ V}$		0.9	1.2	V
t_{rr}	$I_F = 50\text{ A}$; $-di_F/dt = 800\text{ A}/\mu\text{s}$; $V_R = 96\text{ V}$		tbd		ns
Q_{RM}			tbd		μC
I_{RM}			tbd		A

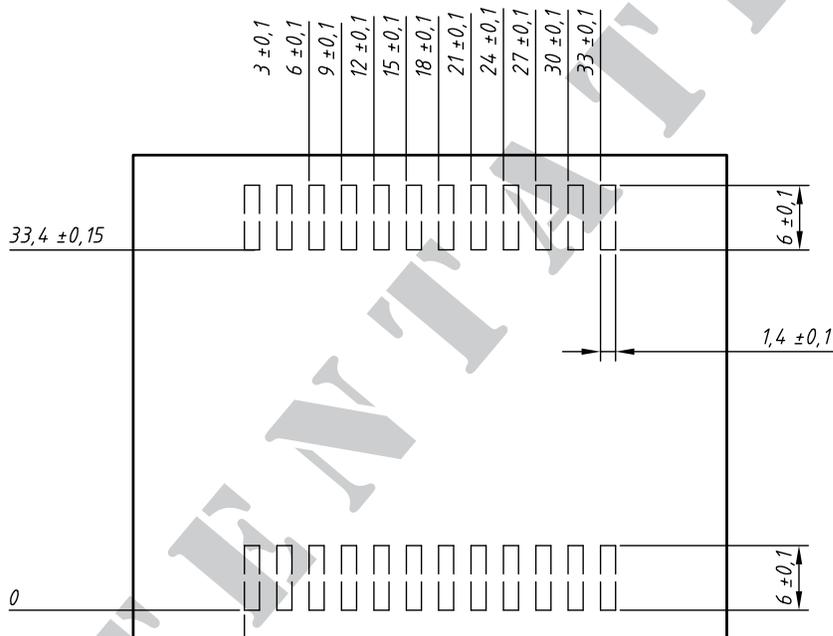
($T_J = 25^\circ\text{C}$, unless otherwise specified)

Component

Symbol	Conditions	Maximum Ratings	
I_{RMS}	per pin in main current paths (P+, N-, L1, L2, L3) may be additionally limited by external connections 2 pins for output L1, L2, L3	75	A
T_J		-55...+175	$^\circ\text{C}$
T_{stg}		-55...+125	$^\circ\text{C}$
V_{ISOL}	$I_{ISOL} \leq 1\text{ mA}$, 50/60 Hz, $f = 1\text{ minute}$	1000	V~
F_C	mounting force with clip	50 - 250	N

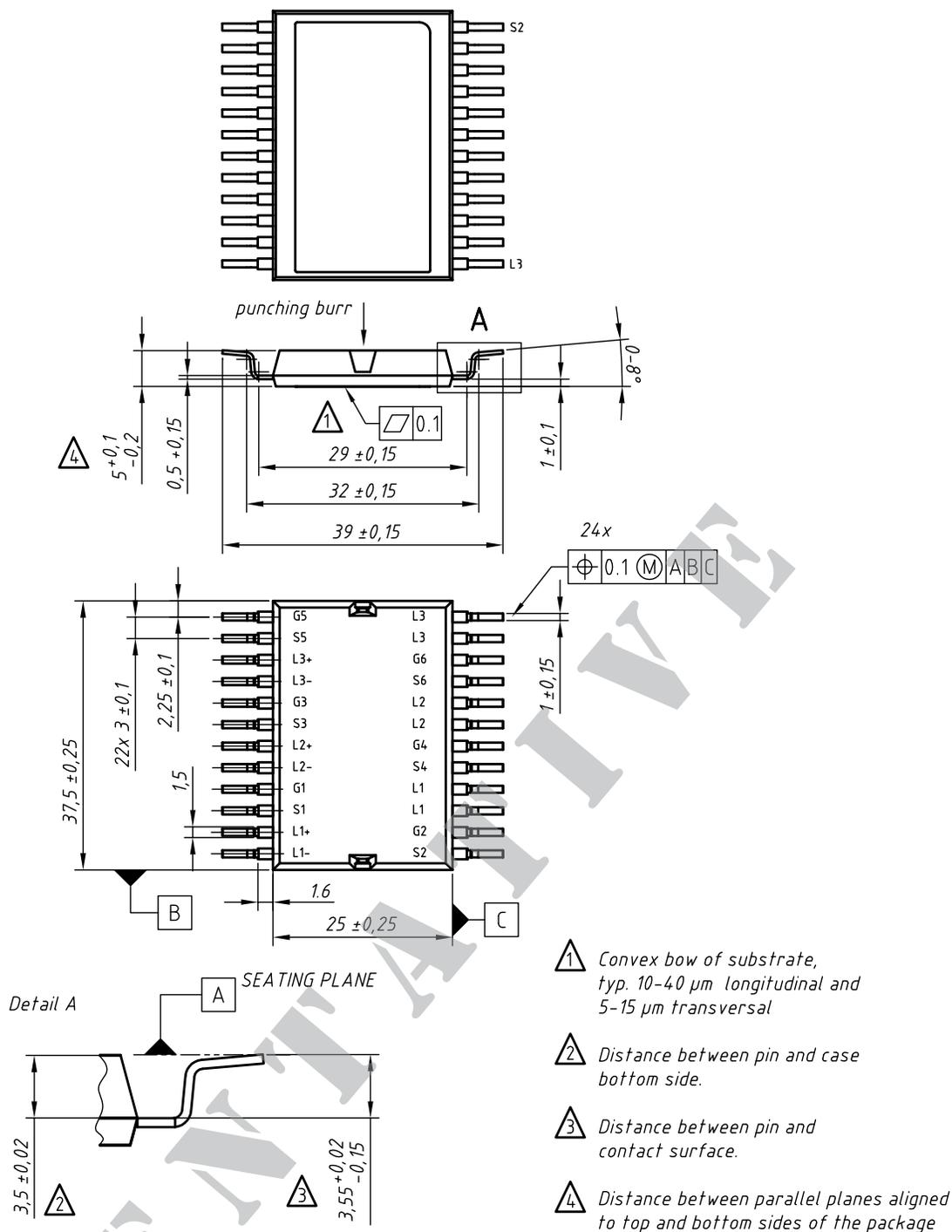
Symbol	Conditions	Characteristic Values		
		min.	typ.	max.
$R_{pin\ to\ chip}^{1)}$			tbd	$\text{m}\Omega$
C_P	coupling capacity between shorted pins and back side metallization		160	pF
Weight		25		g

¹⁾ $V_{DS} = I_D \cdot (R_{DS(on)} + 2R_{Pin\ to\ Chip})$



Remarks:

- 1) pin layout / dimensions are conditionally
- 2) soldering paste thickness: 200 μm



contact pin:

- galv. tin plating, per pin side: Sn 10...25 μ m, undercoating Ni 0,2...1 μ m
- stamping edges may be free of tin
- punching burr: $\leq 0,05$ mm

Leads	Ordering	Part Name & Packing Unit Marking	Part Marking	Delivering Mode	Base Qty.	Ordering Code
SMD	Standard	GMM 3x60-015X2 - SMD	GMM 3x60-015X2	Blister	28	510635

IXYS reserves the right to change limits, test conditions and dimensions.

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